

# **Enhancement Mode N-Channel Power MOSFET**

 $TO-263/NMOS/30V/\pm20V/1.5V/140A/3.0m\Omega$ 

Rev0.5





# 30V, 3.0mΩ, 140A, N-Channel MOSFET

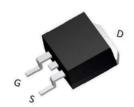
#### 1.Features

- ◆ Advanced Trench Technology
- ◆ Excellent R<sub>DS(ON)</sub> and Low Gate Charge
- ◆ Lead Free

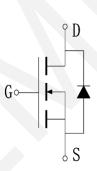
$V_{\text{DS}}$	$R_{DS(on)}$ Typ.	I <sub>D</sub> Max.
30V	3.0mΩ @ 10V	4404
	4.0mΩ @ 4.5V	140A

#### 2.Applications

- Load Switch
- PWM Application
- Power Management



TO-263 Pin Description



Schematic Diagram

## 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP30H40KF	WP30H40	TO-263	800	4,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	30	V
Gate to Source Voltage	V <sub>GSS</sub>	±20	V
Drain Current (DC)	I <sub>D</sub>	140	А
Drain Current (Pulse), PW≤300μs	I <sub>DP</sub>	560	А
Total Dissipation	P <sub>D</sub>	347	W
Avalanche Energy, Single Pulsed	E <sub>AS</sub>	210	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



## 5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to Ambient	Reja	30	°C/W
Junction to case	Rejc	0.36	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

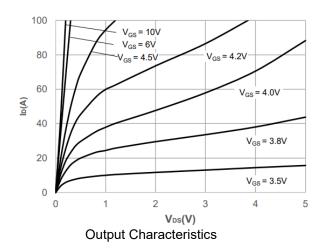
## 6.Electrical Characteristics at Ta=25°C (Note 3)

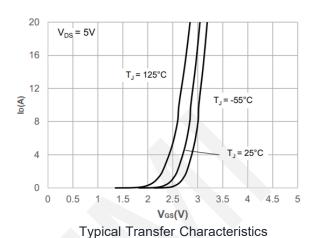
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = 250 \mu A$ , $V_{GS} = 0 V$	30			V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V			1	μA
Gate to Source Leakage Current	I <sub>GSS1</sub>	$V_{GS} = \pm 20V$ , $V_{SS} = 0V$			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	1.0	1.5	2.5	V
Static Drain to Source On-State		I <sub>D</sub> =50A, V <sub>GS</sub> = 10V	-	3.0	3.5	mΩ
Resistance	R <sub>DS(on)</sub>	$I_D = 30A$ , $V_{GS} = 4.5V$	-	4.0	6.0	mΩ
Input Capacitance	Ciss	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V,		3650		pF
Output Capacitance	Coss			494		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	Frequency=1.0MHz		366		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 15V, I <sub>D</sub> =30A		10		ns
Rise Time	t <sub>r</sub>			19		ns
Turn-off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 10V,$ $R_{GEN} = 3\Omega,$		50		ns
Fall Time	t <sub>f</sub>			20		ns
	Qg	$V_{DD}$ = 30V, $V_{GS}$ = 0 to 10V, $I_{D}$ = 15A		67		nC
Total Gate Charge	Qgs			11		nC
	Q <sub>gd</sub>			19		nC
Diode Forward Voltage	$V_{FSD}$	I <sub>S</sub> = 50A, V <sub>GS</sub> = 0			1.2	V

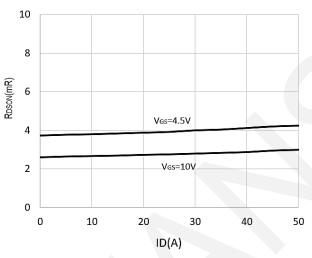
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

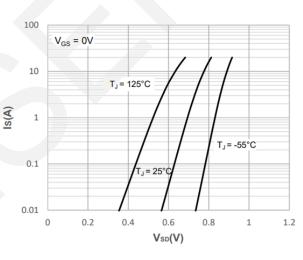


## 7. Typical electrical and thermal characteristics

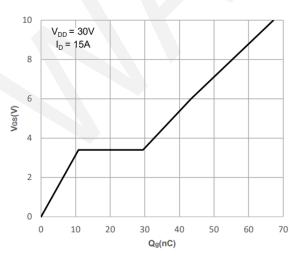




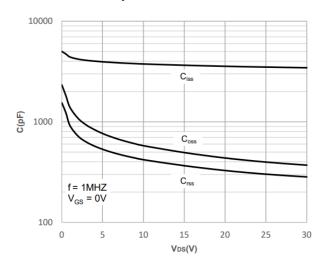








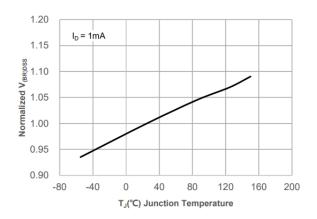
**Body Diode Characteristics** 

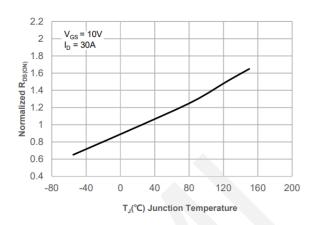


Gate Charge Characteristics

Capacitance Characteristics

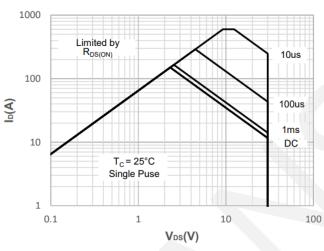






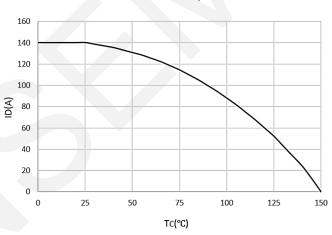
Normalized Breakdown Voltage vs.

Junction Temperature

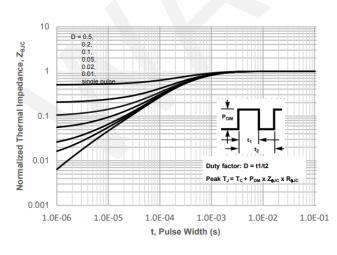


Normalized on Resistance vs.

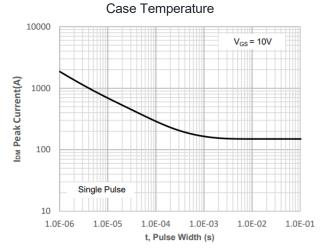
Junction Temperature



Maximum Safe Operating Area



Maximum Continuous Drain Current vs.

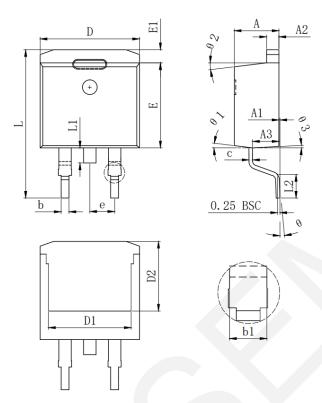


Normalized Maximum Transient Thermal Impedance

Peak Current Capacity



# 8.Package Dimensions



SYMBOL	MILLIMETER			
SIMDOL	MIN	Typ.	MAX	
A	4. 370	4. 570	4. 770	
A1	0.000		0. 250	
A2	1. 220	1. 270	1. 420	
A3	2. 490	2.690	2. 890	
b	0. 700	0.810	0.960	
b1	1.170	1. 270	1. 470	
С	0.300	0.380	0. 530	
D	9.860	10. 160	10. 360	
D1	8. 400 REF			
D2		7.073 REF		
Е	8. 500	8. 700	8. 900	
E1	1.070	1.270	1. 470	
е	2.540 TYP			
L	14. 700	15. 100	15. 500	
L1	1.400	1.550	1.700	
L2	2.000	2.300	2.600	
θ	0°		9°	
θ1	7° TYP			
θ2	7° TYP			
θ3	3° TYP			



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